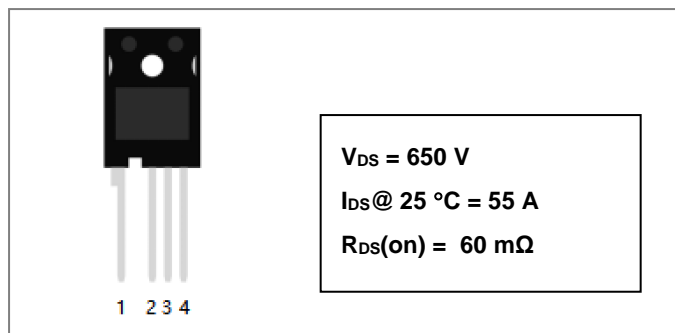


# S1M0060065K

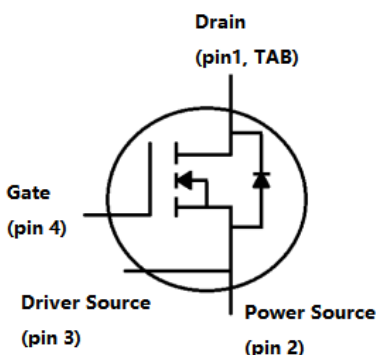
## 650V Silicon Carbide Power MOSFET



### Description

S1M0060065K is a single SiC Power MOSFET packaged in a TO-247-4 case. The device is a high voltage n-channel enhancement mode MOSFET which has very low total conduction losses and very stable switching characteristics over temperature extremes. The S1M0060065K is ideal for energy sensitive, high frequency applications in challenging environments.

### Circuit Diagram



### Features

- Positive temperature characteristics, easy to parallel.
- Low on-resistance typ.  $R_{DS(on)} = 60\text{ m}\Omega$ .
- Fast switching speed and low switching losses.
- Very fast and robust intrinsic body diode.
- Process of non-bright tin electroplating.
- “-A” is an AEC-Q101 qualified device.

### Applications

- EV Fast Charging Modules
- EV On-Board Chargers
- Solar Inverters
- Online UPS/Industrial UPS
- SMPS (Switch Mode Power Supplies)
- DC-DC Converters
- ESS (Energy Storage Systems)

**Maximum Ratings ( $T_A = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified)**

Characteristics	Symbol	Conditions	Min.	Typ.	Max.	Units	Note
Drain - Source Voltage	$V_{DSmax}$	$V_{GS} = 0\text{ V}$ , $I_D = 100\text{ }\mu\text{A}$			650	V	
Gate - Source Voltage (dynamic)	$V_{GSmax}$	AC ( $f > 1\text{ Hz}$ )	-10		+25	V	
Gate - Source Voltage (static)	$V_{GSop}$	Static		-4 / +18		V	[1]
Continuous Drain Current	$I_D$	$V_{GS} = 18\text{ V}$ , $T_C = 25\text{ }^{\circ}\text{C}$		55		A	
		$V_{GS} = 18\text{ V}$ , $T_C = 100\text{ }^{\circ}\text{C}$		39			
Pulsed Drain Current	$I_{D(pulse)}$	Pulse width $t_P$ limited by $T_{Jmax}$		99		A	
Power Dissipation	$P_D$	$T_C = 25\text{ }^{\circ}\text{C}$		307		W	

[1] Recommended turn off gate voltage is -4 V. Recommended turn on gate voltage is 18 V. Do not use with  $V_{GSON} < 15\text{ V}$ .

**Electrical Characteristics ( $T_A = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified)**

Characteristics	Symbol	Conditions	Min.	Typ.	Max.	Units
Drain Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$ , $I_D = 100\text{ }\mu\text{A}$	650			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 5\text{ mA}$	2	2.8	4	V
		$V_{DS} = V_{GS}$ , $I_D = 5\text{ mA}$ , $T_J = 175\text{ }^{\circ}\text{C}$		2.1		V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$		1	100	$\mu\text{A}$
Gate Source Leakage Current	$I_{GSS}$	$V_{GS} = 18\text{ V}$ , $V_{DS} = 0\text{ V}$		10	250	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 18\text{ V}$ , $I_D = 15\text{ A}$	42	60	79	$\Omega$
		$V_{GS} = 18\text{ V}$ , $I_D = 15\text{ A}$ , $T_J = 175\text{ }^{\circ}\text{C}$		65		$\Omega$
Transconductance	$g_{fs}$	$V_{DS} = 18\text{ V}$ , $I_{DS} = 15\text{ A}$		8		S
		$V_{DS} = 18\text{ V}$ , $I_{DS} = 15\text{ A}$ , $T_J = 175\text{ }^{\circ}\text{C}$		6		S
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{ V}$		1660		pF
Output Capacitance	$C_{oss}$	$V_{DS} = 650\text{ V}$		139		
Reverse Transfer Capacitance	$C_{rss}$	$V_{AC} = 25\text{ mV}$		9		
$C_{oss}$ Stored Energy	$E_{oss}$	$f = 1\text{ MHz}$		13		$\mu\text{J}$
Turn-On Switching Energy	$E_{on}$	$V_{DS} = 400\text{ V}$ , $V_{GS} = -4 / 18\text{ V}$		94		$\mu\text{J}$
Turn-Off Switching Energy	$E_{off}$	$I_D = 15\text{ A}$ , $R_{G(ext)} = 2.5\text{ }\Omega$ , $L = 99\text{ }\mu\text{H}$		21		
Turn-On Delay Time	$t_{d(on)}$	$V_{DS} = 400\text{ V}$ , $V_{GS} = -4 / 18\text{ V}$		28		ns
Rise Time	$t_r$	$I_D = 15\text{ A}$ , $R_{G(ext)} = 2.5\text{ }\Omega$		16		

**Technical Data**  
**Data Sheet N2911, REV.-**
**RoHS**

Turn-Off Delay Time	$t_{d(off)}$	Inductive Load Timing relative to VDS Per IEC60747-8-4 pg 83		28		
Fall Time	$t_f$			10		
Internal Gate Resistance	$R_{G(int)}$	$f = 1 \text{ MHz}, AC = 25 \text{ mV}$		2		$\Omega$
Gate to Source Charge	$Q_{gs}$	$V_{DS} = 400 \text{ V}, V_{GS} = -4 / 18 \text{ V}$ $I_D = 15 \text{ A}$ Per IEC60747-8-4 pg 21		21.9		nC
Gate to Drain Charge	$Q_{gd}$			20.3		
Total Gate Charge	$Q_g$			62.5		

**Reverse Diode Characteristics ( $T_A = 25^\circ\text{C}$ , unless otherwise specified)**

Characteristics	Symbol	Conditions	Typ.	Max.	Units
Diode Forward Voltage	$V_{SD}$	$V_{GS} = -4 \text{ V}, I_{SD} = 7.5 \text{ A}$	4.5		V
	$V_{SD}$	$V_{GS} = -4 \text{ V}, I_{SD} = 7.5 \text{ A}, T_J = 175^\circ\text{C}$	4.0		V
Continuous Diode Forward Current	$I_S$	$V_{GS} = -4 \text{ V}, T_C = 25^\circ\text{C}$	26		A
Reverse Recovery Time	$t_{rr}$	$V_{GS} = -4 \text{ V}, I_{SD} = 15 \text{ A}, T_J = 25^\circ\text{C}$ $V_R = 400 \text{ V}$ $di/dt = \text{A} / \mu\text{s}$	15		ns
Reverse Recovery Charge	$Q_{rr}$		107		nC
Peak Reverse Recovery Current	$I_{rm}$		12		A

## Thermal-Mechanical Specifications

Characteristics	Symbol	Condition	Specification	Units
Junction Temperature	$T_J$	-	-55 to +175	°C
Storage Temperature	$T_{stg}$	-	-55 to +175	°C
Typical Thermal Resistance Junction to Case	$R_{\theta JC}$	DC operation	0.49	°C / W

## Ordering Information

Device	Package	Shipping
S1M0060065K	TO-247-4	30pcs / tube

## Marking Diagram



Where XXXXX is YYWWL

S1M = Device Type  
 0060 =  $R_{DS(on)}$   
 065 = Reverse Voltage (650V)  
 K = Package  
 SSG = SSG  
 YY = Year  
 WW = Week  
 L = Lot Number

**Cautions:** Molding resin  
 Epoxy resin UL:94V-0

## Ratings and Characteristics Curves

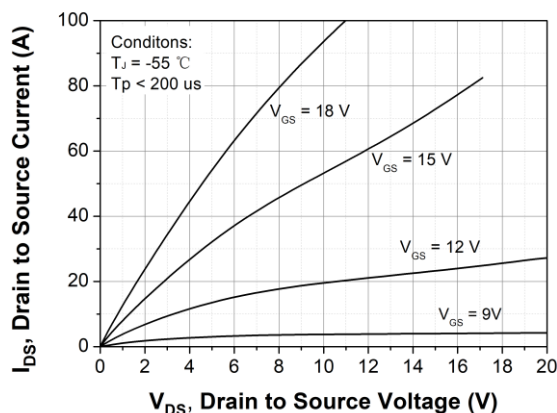


Figure 1. Output Characteristics  $T_J = -55\text{ }^{\circ}\text{C}$

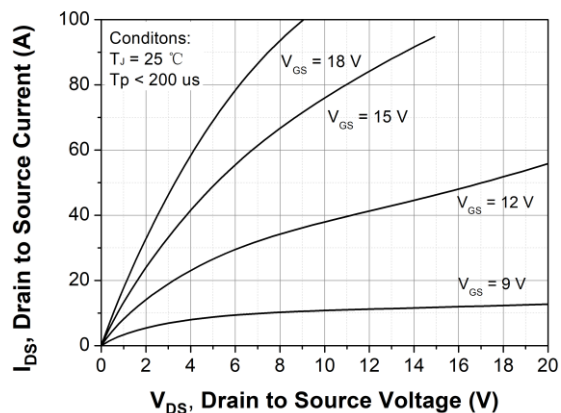


Figure 2. Output Characteristics  $T_J = 25\text{ }^{\circ}\text{C}$

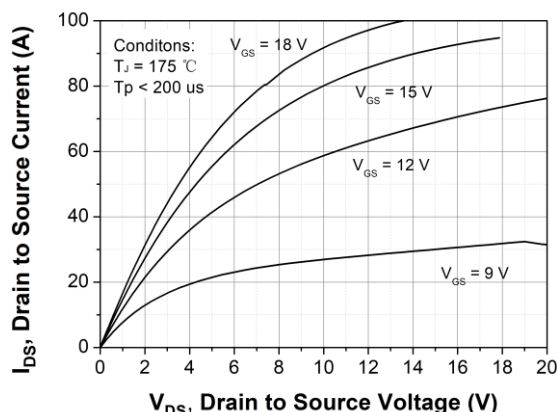


Figure 3. Output Characteristics  $T_J = 175\text{ }^{\circ}\text{C}$

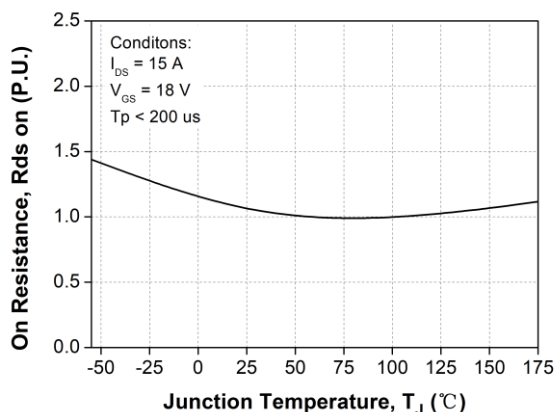


Figure 4. Normalized On-Resistance vs. Temperature

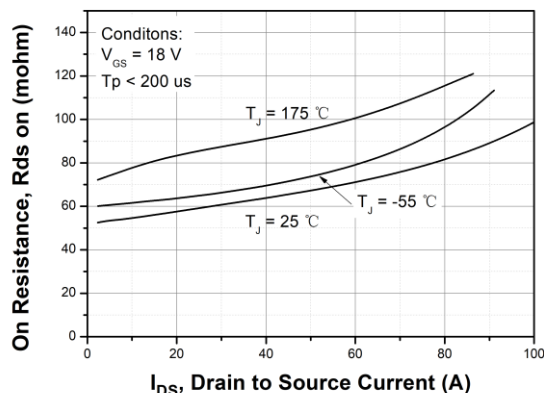


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures

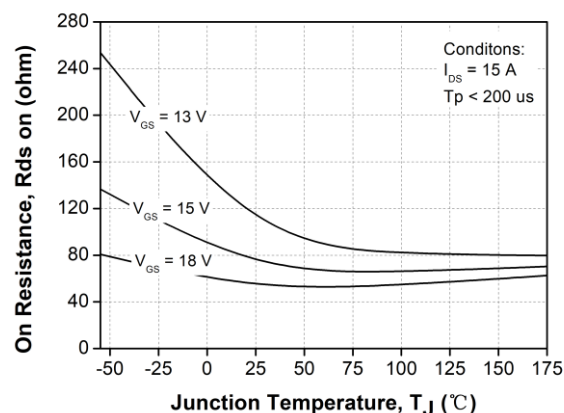
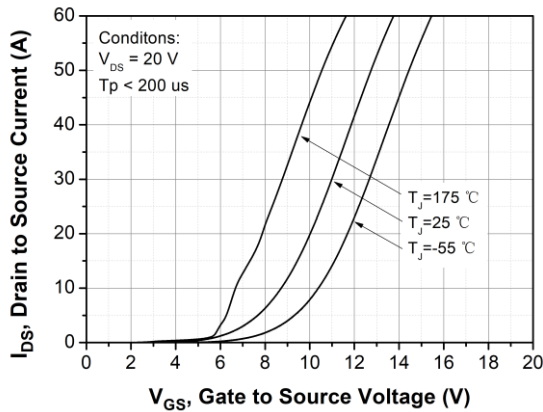
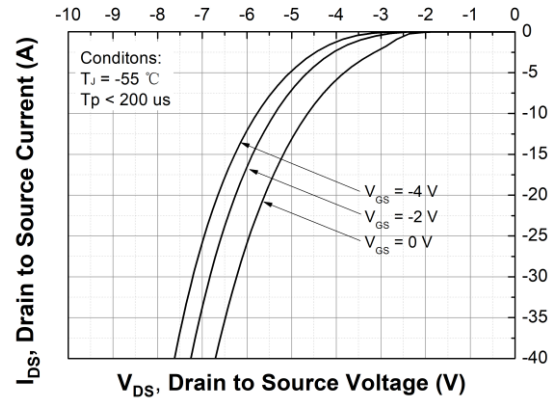


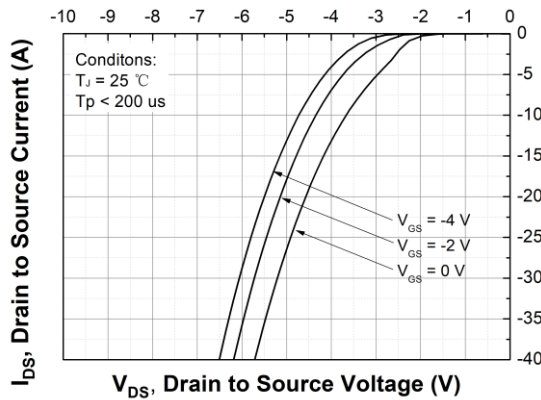
Figure 6. On-Resistance vs. Temperature  
For Various Gate Voltage



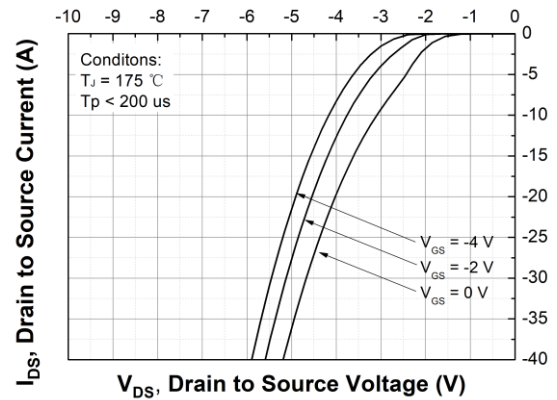
**Figure 7. Transfer Characteristic for Various Junction Temperatures**



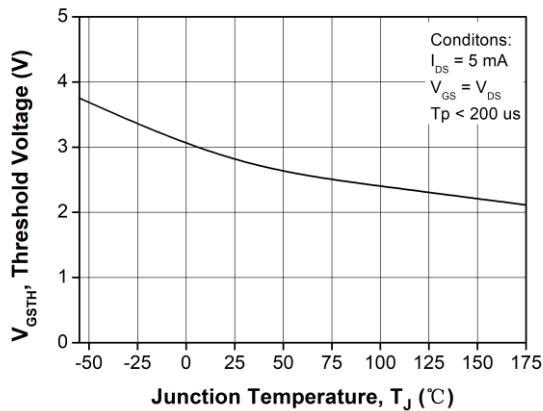
**Figure 8. Body Diode Characteristic at  $T_J = -55\text{ °C}$**



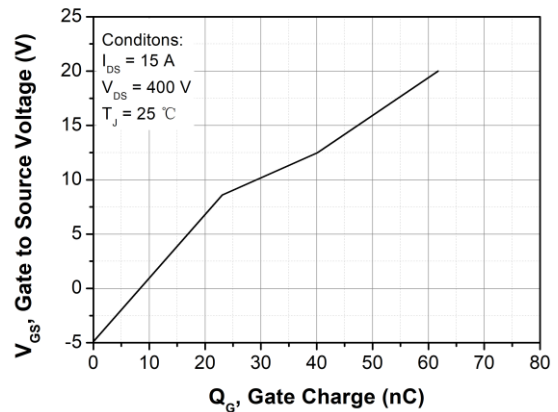
**Figure 9. Body Diode Characteristic at  $T_J = 25\text{ °C}$**



**Figure 10. Body Diode Characteristic at  $T_J = 175\text{ °C}$**



**Figure 11. Threshold Voltage vs. Temperature**



**Figure 12. Gate Charge Characteristic**

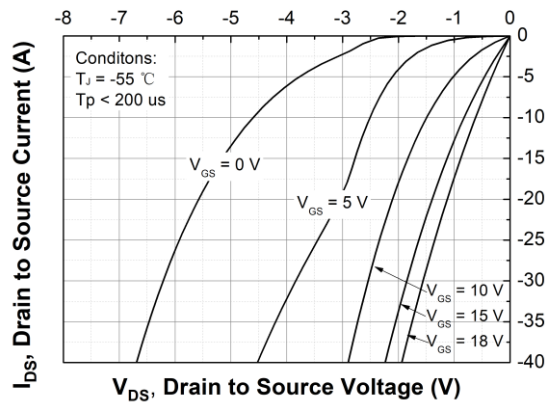


Figure 13. 3rd Quadrant Characteristic at  $T_J = -55\text{ }^{\circ}\text{C}$

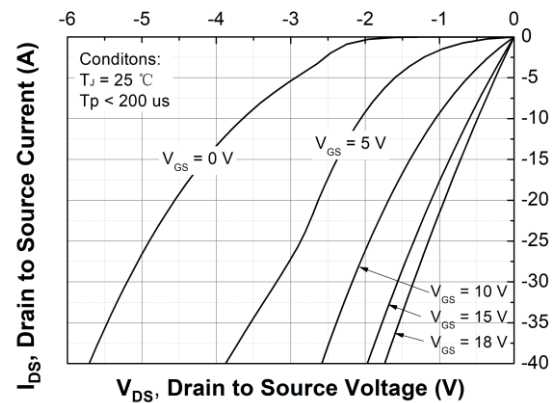


Figure 14. 3rd Quadrant Characteristic at  $T_J = 25\text{ }^{\circ}\text{C}$

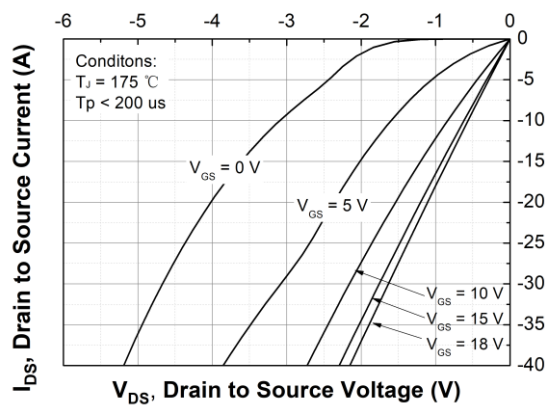


Figure 15. 3rd Quadrant Characteristic at  $T_J = 175\text{ }^{\circ}\text{C}$

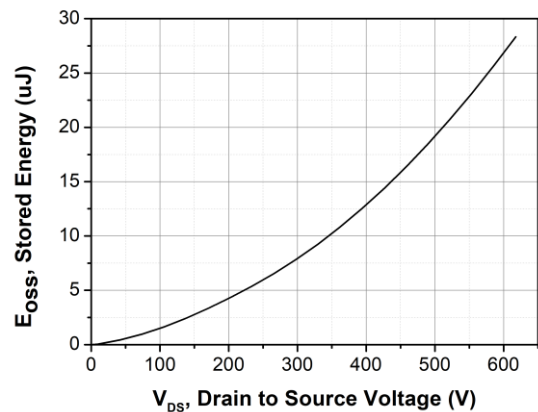


Figure 16. Output Capacitor Stored Energy

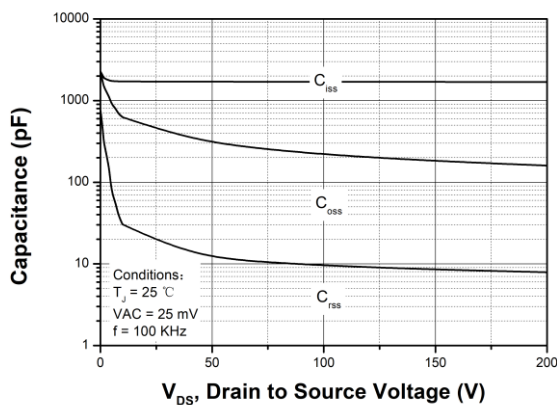


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200 V)

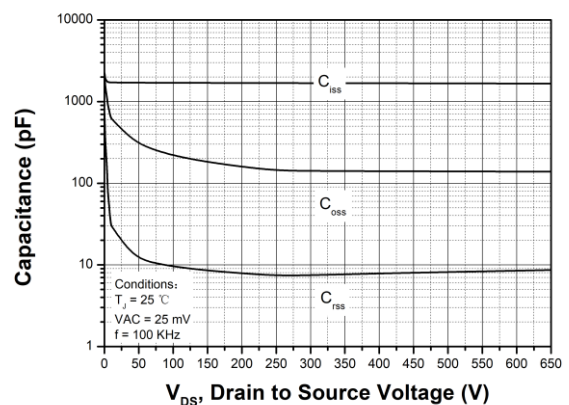


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650 V)



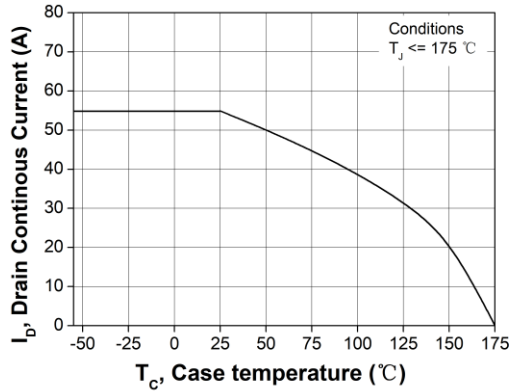


Figure 19. Continuous Drain Current Derating vs. Case Temperature

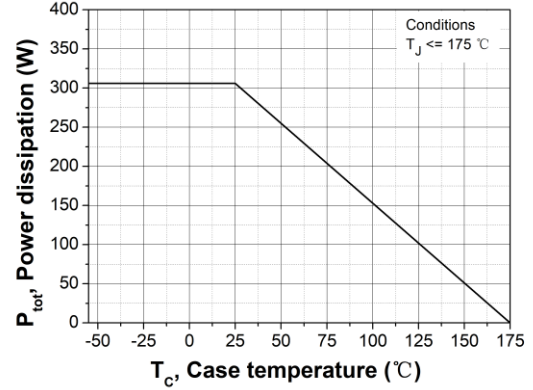


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

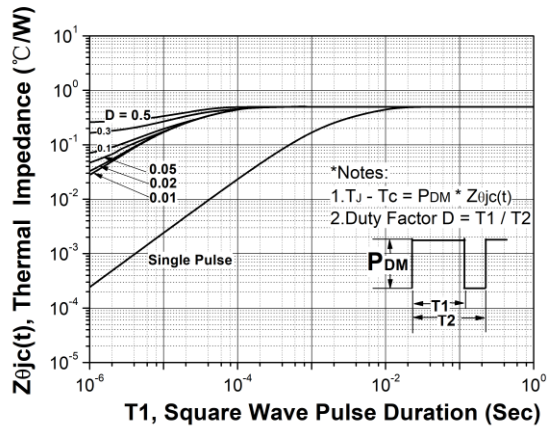


Figure 21. Transient Thermal Impedance (Junction - Case)

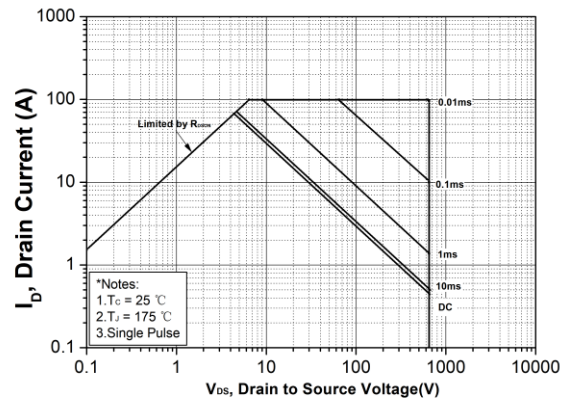


Figure 22. Safe Operating Area

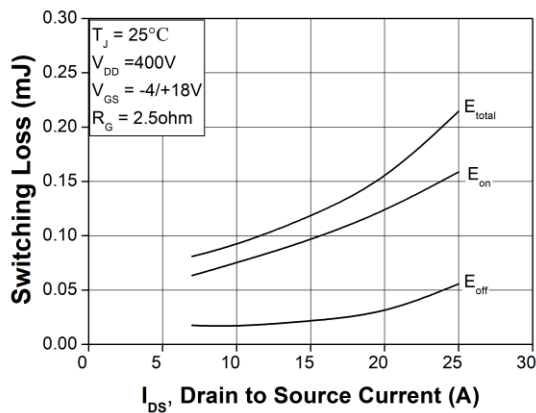


Figure 23. Clamped Inductive Switching Energy vs. Drain Current (VDD = 400V)

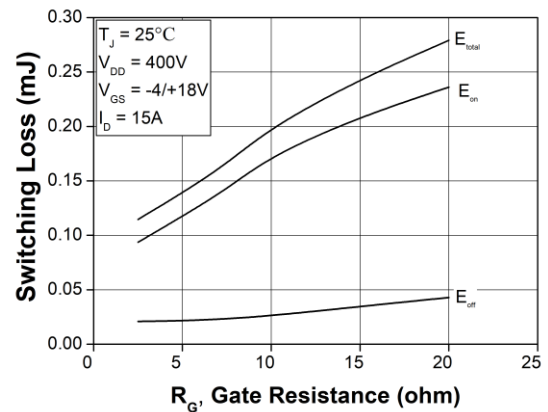


Figure 24. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

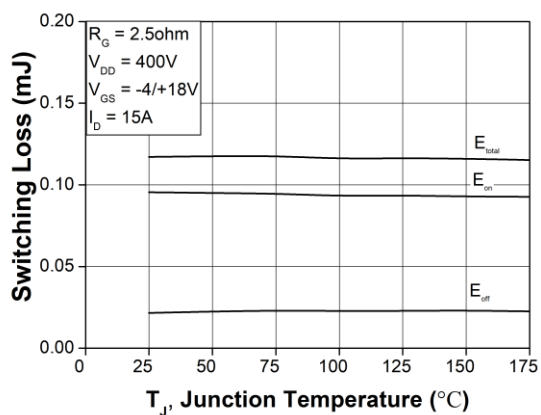


Figure 25. Clamped Inductive Switching Energy vs. Temperature

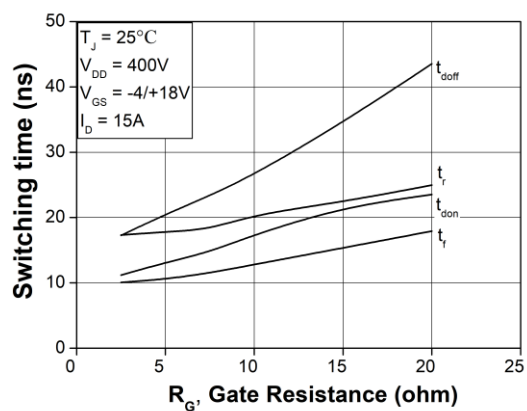
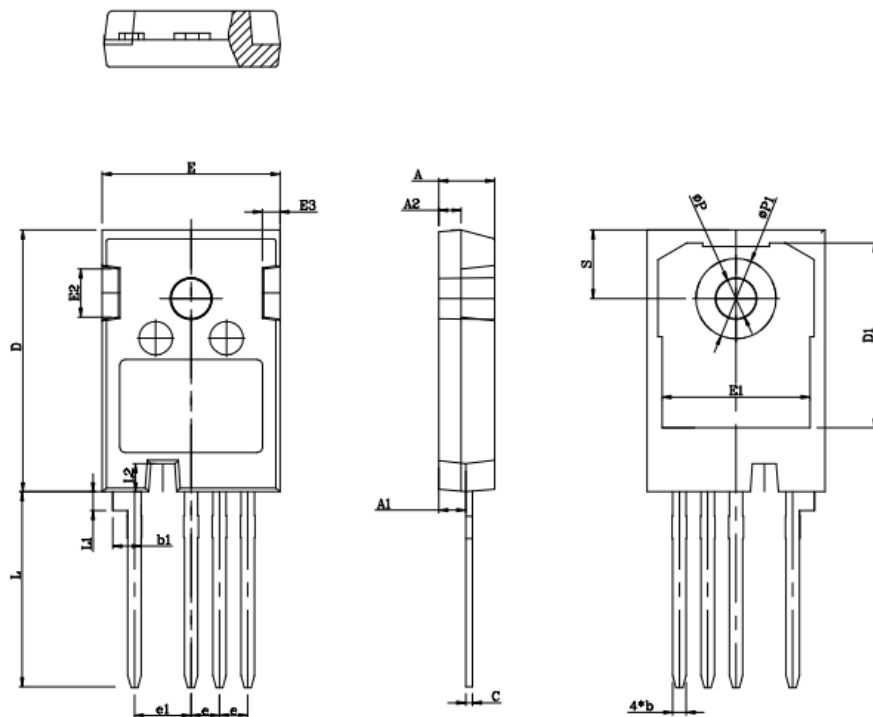


Figure 26. Switching Times vs.  $R_{G(\text{ext})}$

**Mechanical Dimensions TO-247-4**



SYMBOL	mm		
	Min	Nom	Max
A	4.80	5.00	5.20
A1	2.23	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b1	2.35	2.55	2.75
c	0.51	0.61	0.75
D	23.30	23.45	23.60
D1	16.25	16.55	16.85
E	15.75	15.94	16.10
E1	13.00	13.26	13.43
E2	4.00	4.30	4.60
E3	1.15	1.45	1.75
e		2.54BSC	
e1		5.08BSC	
L	17.31	17.47	17.82
L1	1.50	1.70	1.90
ØP	3.51	3.60	3.65
ØP1	7.08	7.19	7.30
S		6.15BSC	

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